

▲ 深圳市泰河电子有限公司

SHENZHEN TH ELECTRONICS CO;LTD

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Product Confirmation

CUSTOMER:			
Product:	声表面谐振器		
Frequency:	R433M		
Model:	F-11 DIP		

承认后请寄回一份

PLS SEND BACK ONE COPY TO US AFTER YOUR APPROVAL

承认結果	客戶签名	客戶承认章	日期	备注
CONCLUSION	SIGNATURE	STAMP	DATE	REMARK
合格				
ACCEPT				
不合格				
REJECT				

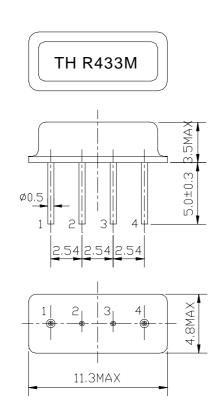
制表:	刘小姐	审核:	
			(公章)

尊敬的客户:请您抽出一点时间,在7-10个工作日内将承认书回签,若未回签,以视默认.谢谢合作!

TH R433M 声表面谐振器F-11 DIP

1. Package Dimension

(F-11)



Unit: mm

Pin No. Function

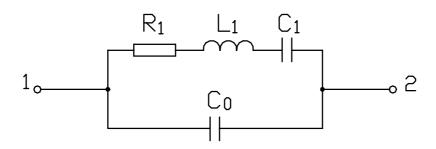
- 1. Input
- 2. Ground
- 3. Ground
- 4. Output

2. Marking

TR433.92M

- Color: Black or Blue
 D: Manufacture's logo
- 3. R1: One-port SAW Resonator4. 433.92: Center Frequency (MHz)

3. Equivalent LC Model



4. Performance

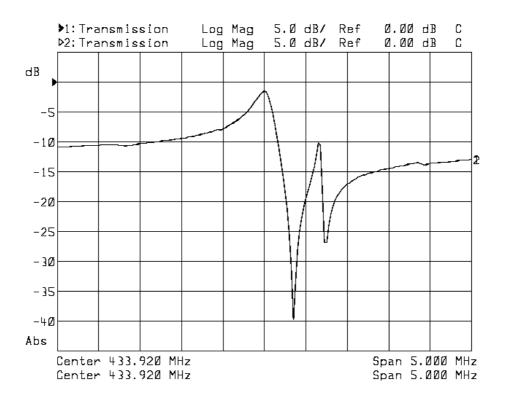
4.1 Maximum Rating

DC Voltage V _{DC}	10V		
AC Voltage V _{PP}	10V (50Hz/60Hz)		
Operation Temperature	-40°C to +85°C		
Storage Temperature	-45°C to +85°C		
RF Power Dissipation	0dBm		

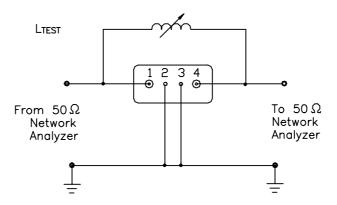
4.2 Electronic Characteristics

Item		Units	Minimum	Typical	Maximum
Center Frequency		MHz	433.845	433.92	433.995
Insertion Loss		dB		1.3	2.5
Quality Factor	Unloaded Q	_		11,000	_
	50 Ω Loaded Q	_	_	2,000	_
Temperature	Turnover Temperature	$^{\circ}$		25	_
Stability	Turnover Frequency	KHz	_	fo	_
	Freq. Temp. Coefficient	ppm/°C²		0.032	_
Frequency Aging		ppm/yr	_	<±10	_
DC Insulation Resistance		ΜΩ	1.0	_	_
RF Equivalent RLC Model	Motional Resistance R ₁	Ω	_	18	26
	Motional Inductance L ₁	μН		86	_
	Motional Capacitance C ₁	fF	_	1.56	_
	Shunt Static Capacitance Co	pF	1.7	2.0	2.3

4.3 Frequency Characteristics



4.4 Test Circuit



Note: Reference temperature shall be $25\pm2^{\circ}$ C. However, the measurement may be carried out at 5° C to 35° C unless there is a dispute.

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5. Reliability

- 5.1 Mechanical Shock: The components shall remain within the electrical specifications after 1000 shocks, acceleration 392 m/s², duration 6 milliseconds.
- 5.2 Vibration Fatigue: The components shall remain within the electrical specifications after loaded vibration at 20 Hz, amplitude 1.5 mm, for 2 hours.
- 5.3 Terminal Strength: The components shall remain within the electrical specifications after pulled 2 kgs weight for 10 seconds towards an axis of each terminal.
- 5.4 High Temperature Storage: The components shall remain within the electrical specifications after being kept at the $85^{\circ}\text{C} \pm 2^{\circ}\text{C}$ for 48 hours, then kept at room temperature for 2 hours.
- 5.5 Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the $-25^{\circ}\text{C} \pm 2^{\circ}\text{C}$ for 48 hours, then kept at room temperature for 2 hours.
- 5.6 Temperature Cycle: The components shall remain within the electrical specifications after 5 cycles of high and low temperature testing (one cycle: 80°C for 30 minutes→25°C for 5 minutes \rightarrow -25 °C for 30 minutes)than kept at room temperature for 2 hours.
- 5.7 Solder-heat Resistance: The components shall remain within the electrical specifications after dipped in the solder at 260°C for 10 ± 1 seconds, then kept at room temperature for 2 hours. (Terminal must be dipped leaving 1.5 mm from the case).
- 5.8 Solder Ability: Solder ability of terminal shall be kept at more than 80% after dipped in the solder flux at $230^{\circ}\text{C} \pm 5^{\circ}\text{C}$ for 5 ± 1 seconds.

6. Remarks

6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning.

6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.